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LM10QML Operational Amplifier and Voltage Reference

Check for Samples: LM10QML

FEATURES

Input offset voltage: 2.0 mV (max) Input offset current: 0.7 nA (max) Input bias current: 20 nA (max)

Reference regulation: 0.1% (max)

Offset voltage drift: 2µV/°C Reference drift: 0.002%/°C

DESCRIPTION

The LM10 is a monolithic linear IC consisting of a precision reference, an adjustable reference buffer and an independent, high quality op amp.

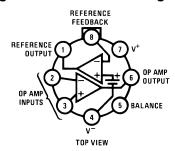
The unit can operate from a total supply voltage as low as 1.1V or as high as 40V, drawing only 270µA. A complementary output stage swings within 15 mV of the supply terminals or will deliver ±20 mA output current with ±0.4V saturation. Reference output can be as low as 200 mV.

The circuit is recommended for portable equipment and is completely specified for operation from a single power cell. In contrast, high output-drive capability, both voltage and current, along with thermal overload protection, suggest it in demanding general-purpose applications.

The device is capable of operating in a floating mode, independent of fixed supplies. It can function as a remote comparator, signal conditioner, SCR controller or transmitter for analog signals, delivering the processed signal on the same line used to supply power. It is also suited for operation in a wide range of voltage- and currentregulator applications, from low voltages to several hundred volts, providing greater precision than existing ICs.

Connection and Functional Diagram

Figure 1. Metal Can Package (H)



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Figure 2. Operational Amplifier Schematic — (Pin numbers are for 8-pin packages)

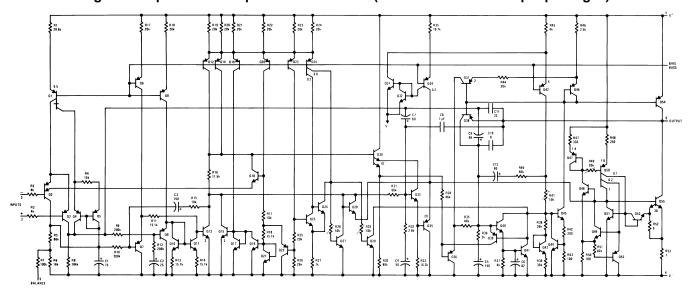
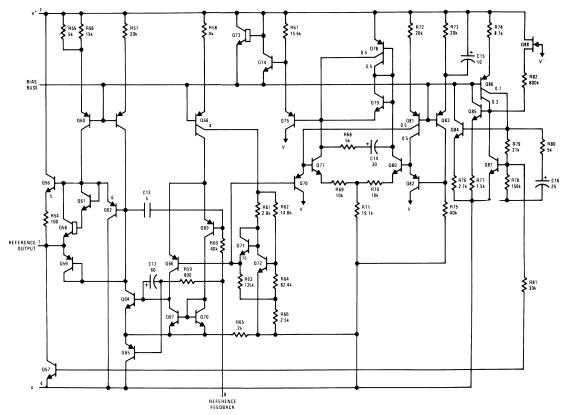


Figure 3. Reference and Internal Regulator Schematic — (Pin numbers are for 8-pin packages)





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

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Absolute Maximum Ratings (1)

Total Supply Voltage	45V
Differential Input Voltage (2)	±40V
Power Dissipation (P _{Dmax}) (3)	Internally Limited
Output Short-circuit Duration (4)	Continuous
Storage Temperature Range	-55°C ≤ T _A ≤ +150°C
Maximum Junction Temperature (T _{Jmax})	150°C
Lead Temperature (Soldering 10 seconds)	300°C
Thermal Resistance	
$\theta_{ m JA}$	
Still Air	150°C
500LF/Min Air flow	45°C
$\theta_{ extsf{JC}}$	
	45°C
ESD	Rating to be determined

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.
- (2) The Input voltage can exceed the supply voltages provided that the voltage from the input to any other terminal does not exceed the maximum differential input voltage and excess dissipation is accounted for when V_I< V_S.
- (3) The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{Jmax} (maximum junction temperature), θ_{JA} (package junction to ambient thermal resistance), and T_A (ambient temperature). The maximum allowable power dissipation at any temperature is P_{Dmax} = (T_{max} T_A)/θ_A or the number given in the Absolute Maximum Ratings, whichever is lower.
- temperature is P_{Dmax} = (T_{Jmax} T_A)/θ_{JA} or the number given in the Absolute Maximum Ratings, whichever is lower..

 (4) Internal thermal limiting prevents excessive heating that could result in sudden failure, but the IC can be subjected to accelerated stress with a shorted output and worst-case conditions.

Table 1. Quality Conformance InspectionMil-Std-883, Method 5005 - Group A

Subgroup	Description	Temp °C
1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55
12	Settling time at	+25
13	Settling time at	+125
14	Settling time at	-55

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LM10H Electrical Characteristics DC Parameters

The following conditions apply to all the following parameters, unless otherwise specified.

DC: At room temperature 1.2V \leq V_S \leq 45V, V_S \leq V_{CM} \leq V \pm 0.85V. DC: At temperature extremes 1.3V \leq V_S \leq 45V, V_S \leq V_{CM} \leq V \pm 1.0V.

Symbol	Parameter	Conditions	Notes	Min	Max	Unit	Sub- groups	
V _{IO}		1 - 0mA		-2.0	2.0	mV	1	
		$I_O = 0$ mA		-3.0	3.0	mV	2, 3	
	Input Offset Voltage	$V_S = 1.2V, I_O = \pm 2mA$		-3.0	3.0	mV	1	
	input Onset Voltage	$V_S = 1.3V, I_O = \pm 2mA$		-4.0	4.0	mV	2, 3	
		$V_S = 4V$, $I_O = \pm 20$ mA		-3.0	3.0	mV	1	
		$V_S = 4V$, $I_O = \pm 15$ mA		-4.0	4.0	mV	2, 3	
I _{IO}	Input Offset Current			-0.7	0.7	nA	1	
יוט	input onset ourrent			-1.5	1.5	nA	2, 3	
l	Input Bias Current				20	nA	1	
I _{IB}	Input bias Current				30	nA	2, 3	
CMRR	Common Mode Painction	V- = 45V 20V < V < 24.2V		93		dB	1	
CIVIKK	Common Mode Rejection	$V_S = 45V, -20V \le V_{CM} \le 24.2V$		87		dB	2, 3	
		$V_S^+ = 0.85V$, -0.35V $\ge V_S^- \ge -44.2V$		90		dB	1	
DCDD		$V_S^+ = 1V$, -0.3V $\ge V_S^- \ge -44.2V$		84		dB	2, 3	
PSRR	Supply Voltage Rejection	$0.85V \le V_S^+ \le 44.6V$, $V_S^- = -0.35V$		96		dB	1	
		$1V \le V_S^+ \le 44.6V$, $V_S^- = -0.3V$		90		dB	2, 3	
V _{RLine}	1: 5 1:		91		dB	1		
	Line Regulation	I _{Ref} = 1mA	85		dB	2, 3		
V_{RLoad}	1 15 10	$V_S = 1.2V, 0 \le I_O \le 1mA$		60		dB	1	
	Load Regulation	$V_S = 1.3V, 0 \le I_O \le 1mA$		57		dB	2, 3	
	0 10 1				400	μA	1	
l _S	Supply Current				500	μA	2, 3	
		$V_S = \pm 20V, I_O = 0A,$		120		K	4	
		$V_0 = \pm 19.95V$		80		K	5, 6	
A _V		$V_S = \pm 2V$, $I_O = \pm 20$ mA, $V_O = \pm 1.4V$		5.0		K	4	
	Large Signal Voltage Gain	$V_S = \pm 2V$, $I_O = \pm 15$ mA, $V_O = \pm 1.4V$		1.5		K	5, 6	
		$V_S^+ = 0.85V$, $V_{CM} = -0.25V$ $V_S^- = -0.35V$, $I_O = \pm 2mA$, $-0.15V \le V_O \le 0.65V$,		1.5		K	4	
		$V_S^+ = 1V$, $V_{CM} = -0.35V$ $V_S^- = -0.3V$, $I_O = \pm 2mA$, $+0.05V \le V_O \le 0.65V$,		0.5		К	5, 6	
A _{VSH}		1.1V ≤ V _{OUT} ≤ 6.1V, -5mA ≤ I _{OUT} ≤ -0.1mA	(1)	14		К	4	
	Shunt Coin	1.2V ≤ V _{OUT} ≤ 6.2V, -5mA ≤ I _{OUT} ≤ -0.1mA	(1)	6.0		К	5, 6	
	Shunt Gain	$1.4V \le V_{OUT} \le 6.4V$, -5mA $\le I_{OUT} \le -0.1$ mA	(1)	8.0		К	4	
		$1.4V \le V_{OUT} \le 6.4V$, $-20mA \le I_{OUT} \le -0.1mA$	(1)	4.0		К	5, 6	

⁽¹⁾ This defines operation in floating applications such as the bootstrapped regulator or two-wire transmitter. Output is connected to the V_S⁺ terminal of the IC and input common mode is referred to V_S (see typical applications). Effect of larger output-voltage swings with higher load resistance can be accounted for by adding the positive-supply rejection error.

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LM10H Electrical Characteristics DC Parameters (continued)

The following conditions apply to all the following parameters, unless otherwise specified. DC: At room temperature 1.2V \leq V_S \leq 45V, V_S \leq V_{CM} \leq V \pm 0.85V.

DC: At temperature extremes 1.3V \leq V_S \leq 45V, V_S \leq V_{CM} \leq V± 1.0V.

Symbol	Parameter	Conditions	Notes	Min	Max	Unit	Sub- groups
	Amplifier Coin	$0.2V \le V_{Ref} \le 35V$, $I_{Ref} = 1mA$		50		K	
A _V	Amplifier Gain			23		K	
V _{Sense}	Feedback Sense Voltage	0.2V ≤ V _{Ref} ≤ 35V,		195	205	mV	
		0 ≤ I _{Ref} ≤ 1 mA		194	206	mV	
I _{Sense}	Facility of Commonst				50	nA	
	Feedback Current				65	nA	
ΔI _S	Sunahi Cumant Chana	0.5V ≤ V _O ≤ 25V		-75	75	μΑ	
	Supply Current Change	$V_S = 5V, 4.5V \le V_O \le 5V$		-60	60	μΑ	
R _I	Land Davidson		(2)		250	ΚΩ	
	Input Resistance		(2)		150	ΚΩ	

⁽²⁾ Guaranteed parameter, not tested,

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Definition of Terms

Input offset voltage: That voltage which must be applied between the input terminals to bias the unloaded output in the linear region.

Input offset current: The difference in the currents at the input terminals when the unloaded output is in the linear region. **Input bias current:** The absolute value of the average of the two input currents.

Input resistance: The ratio of the change in input voltage to the change in input current on either input with the other grounded.

Large signal voltage gain: The ratio of the specified output voltage swing to the change in differential input voltage required to produce it.

Shunt gain: The ratio of the specified output voltage swing to the change in differential input voltage required to produce it with the output tied to the V_S^+ terminal of the IC. The load and power source are connected between the V_S^+ and V_S^- terminals, and input common-mode is referred to the V_S^- terminal.

Common-mode rejection: The ratio of the input voltage range to the change in offset voltage between the extremes. **Supply-voltage rejection:** The ratio of the specified supply-voltage change to the change in offset voltage between the extremes.

Line regulation: The average change in reference output voltage over the specified supply voltage range.

Load regulation: The change in reference output voltage from no load to that load specified.

Feedback sense voltage: The voltage, referred to V_s , on the reference feedback terminal while operating in regulation. **Reference amplifier gain:** The ratio of the specified reference output change to the change in feedback sense voltage required to produce it.

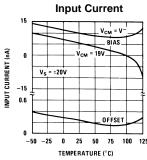
Feedback current: The absolute value of the current at the feedback terminal when operating in regulation.

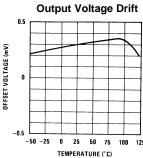
Supply current: The current required from the power source to operate the amplifier and reference with their outputs unloaded and operating in the linear range.

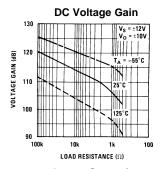


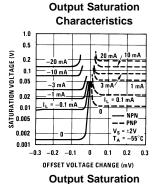
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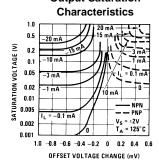
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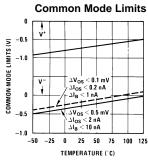


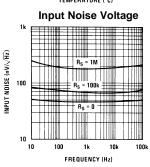


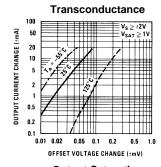


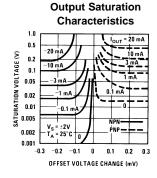


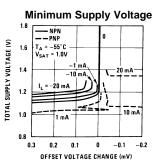




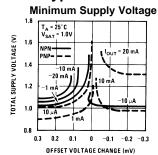


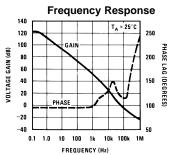


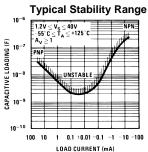




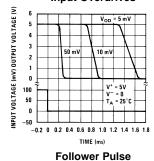
Typical Performance Characteristics (Op Amp) (continued)

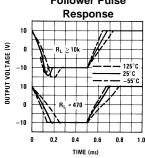


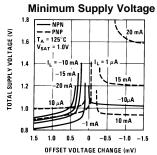


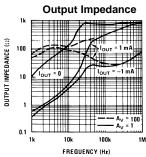


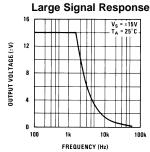
Comparator Response Time For Various Input Overdrives



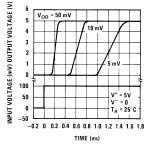


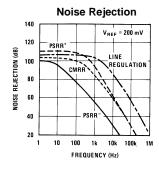






Comparator Response Time For Various Input Overdrives





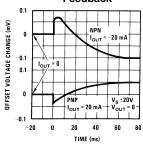


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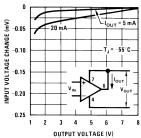
Typical Performance Characteristics (Op Amp) (continued)



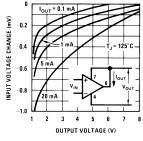
Thermal Gradient Feedback



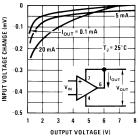
Shunt Gain



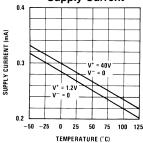
Shunt Gain



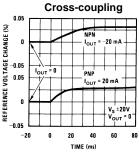
Shunt Gain



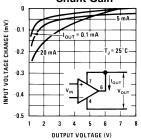
Supply Current



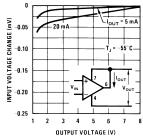
Thermal Gradient



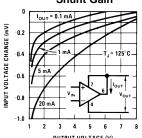
Shunt Gain



Shunt Gain

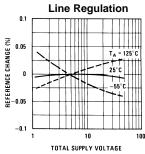


Shunt Gain

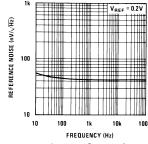


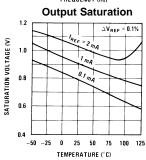


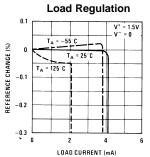
Typical Performance Characteristics (Reference)

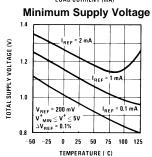


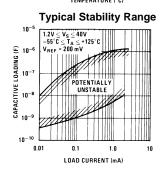
Reference Noise Voltage









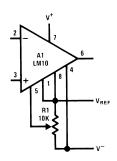


Typical Applications

(Pin numbers are for devices in 8-pin packages)

Op Amp Offset Adjustment

Figure 4. Standard



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(Pin numbers are for devices in 8-pin packages)

Figure 5. Limited Range

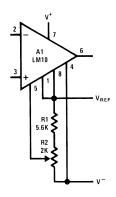
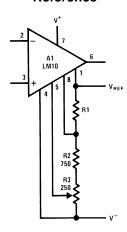


Figure 6. Limited Range With Boosted Reference



Positive Regulators

Figure 7. Low Voltage

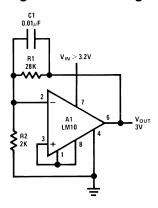




Figure 8. Best Regulation

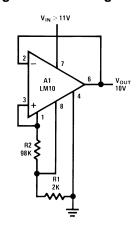
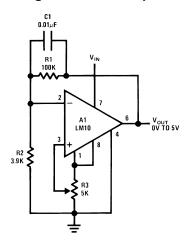


Figure 9. Zero Output



Use only electrolytic output capacitors.

Figure 10. Current Regulator

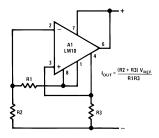
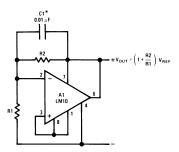


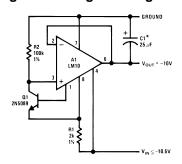


Figure 11. Shunt Regulator



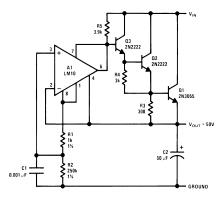
Required For Capacitive Loading

Figure 12. Negative Regulator



*Electrolytic

Figure 13. Precision Regulator

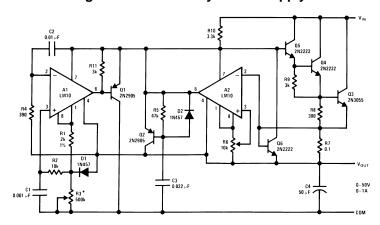


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(Pin numbers are for devices in 8-pin packages)

Figure 14. Laboratory Power Supply



 $V_0=10^{-4}$ R3

Figure 15. HV Regulator

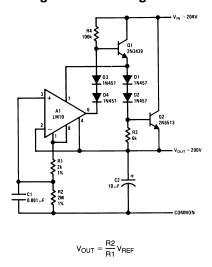
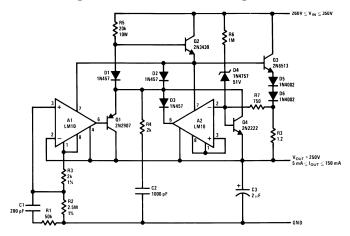


Figure 16. Protected HV Regulator

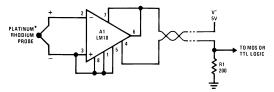




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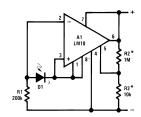
(Pin numbers are for devices in 8-pin packages)

Figure 17. Flame Detector



*800°C Threshold Is Established By Connecting Balance To V_{Ref}.

Figure 18. Light Level Sensor



*Provides Hysteresis

Figure 19. Remote Amplifier

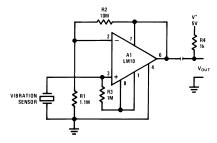


Figure 20. Remote Thermocouple Amplifier

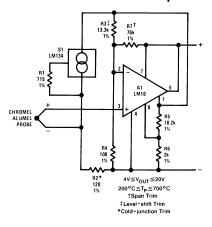




Figure 21. Transmitter for Bridge Sensor

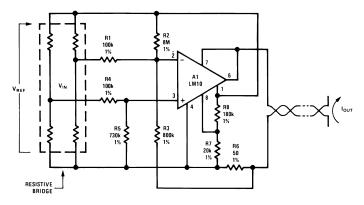
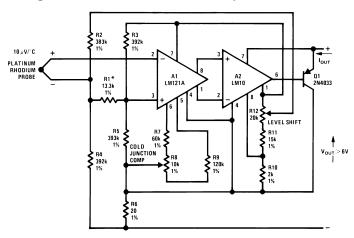


Figure 22. Precision Thermocouple Transmitter



10 mA ≤ I_{OUT} ≤50 mA $500^{\circ}\text{C} \le \text{T}_{\text{P}} \le 1500^{\circ}\text{C}$ *Gain Trim

Figure 23. Resistance Thermometer Transmitter

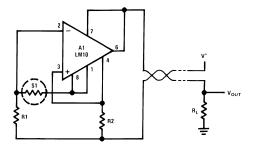
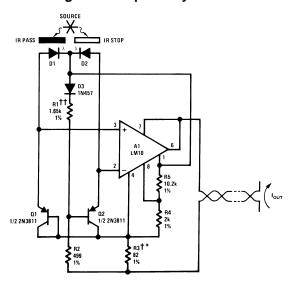


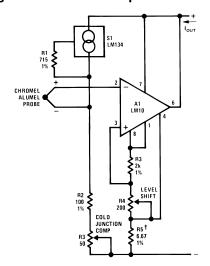


Figure 24. Optical Pyrometer



††Level-shift Trim *Scale Factor Trim †Copper Wire Wound $1 \text{ mA} \le |_{\text{DUT}} \le 5 \text{ mA}$ $0.01 \le \frac{|_{\text{DZ}}}{|_{\text{D1}}} \le 100$

Figure 25. Thermocouple Transmitter



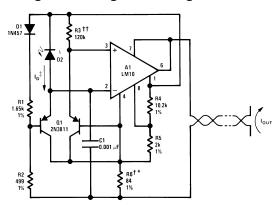
 $200^{\circ}\text{C} \le \text{T}_{\text{p}} \le 700^{\circ}\text{C}$ 1 mA $\le \text{I}_{\text{OUT}} \le 5$ mA †Gain Trim

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INSTRUMENTS

(Pin numbers are for devices in 8-pin packages)

Figure 26. Logarithmic Light Sensor



1 mA \leq I_{OUT} \leq 5 mA \ddagger 50 μ A \leq I_D \leq 500 μ A \ddagger †Center Scale Trim †Scale Factor Trim *Copper Wire Wound

Figure 27. Battery-level Indicator

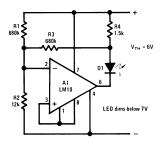
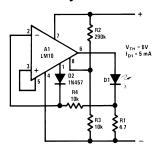


Figure 28. Battery-threshold Indicator



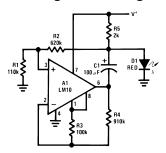
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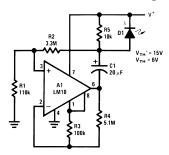
(Pin numbers are for devices in 8-pin packages)

Figure 29. Single-cell Voltage Monitor



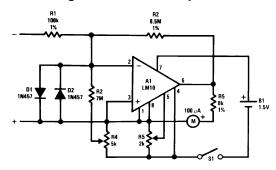
Flashes Above 1.2V Rate Increases With Voltage

Figure 30. Double-ended Voltage Monitor



Flash Rate Increases Above 6V and Below 15V

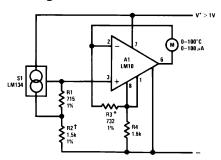
Figure 31. Meter Amplifier



Input 10 mV, 100nA Full-Scale

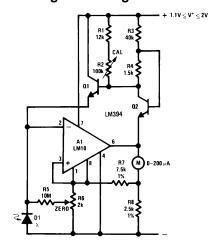


Figure 32. Thermometer



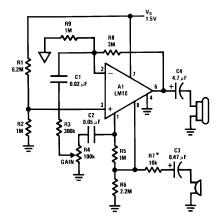
*Trim For Span †Trim For Zero

Figure 33. Light Meter



 $1 \le \lambda/\lambda_0 \le 10^5$

Figure 34. Microphone Amplifier

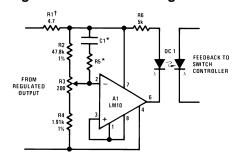


 Z_{OUT} ~680 Ω @ 5 kHz $A_V \le 1k$ f_1 ~100 Hz f_2 ~5 kHz R_L ~500 *Max Gain Trim

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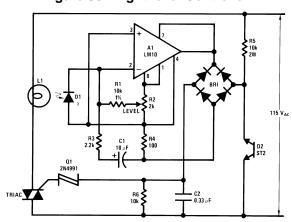
(Pin numbers are for devices in 8-pin packages)

Figure 35. Isolated Voltage Sensor



†Controls "Loop Gain"
*Optional Frequency Shaping

Figure 36. Light-level Controller



(1) Circuit descriptions available in application note AN-211.

Application Hints

With heavy amplifier loading to V_S^- , resistance drops in the V_S^- lead can adversely affect reference regulation. Lead resistance can approach 1Ω . Therefore, the common to the reference circuitry should be connected as close as possible to the package.

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Table 2. Revision History

Date Released	Revision	Section	Changes
10/26/2010	Α	New release to corporate format	1 MDS converted to standard corporate format. MNLM10-X Rev 0AL will be archived



PACKAGE OPTION ADDENDUM

26-Jan-2013

PACKAGING INFORMATION

www.ti.com

Orderable Device	Status	Package Type	_		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
5962-8760401GA	ACTIVE	ТО	NEV	8	20	TBD	POST-PLATE	Level-1-NA-UNLIM		LM10H/883 5962-8760401GA Q ACO 5962-8760401GA Q >T	Samples
LM10H/883	ACTIVE	ТО	NEV	8	20	TBD	POST-PLATE	Level-1-NA-UNLIM		LM10H/883 5962-8760401GA Q ACO 5962-8760401GA Q >T	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, Tl Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

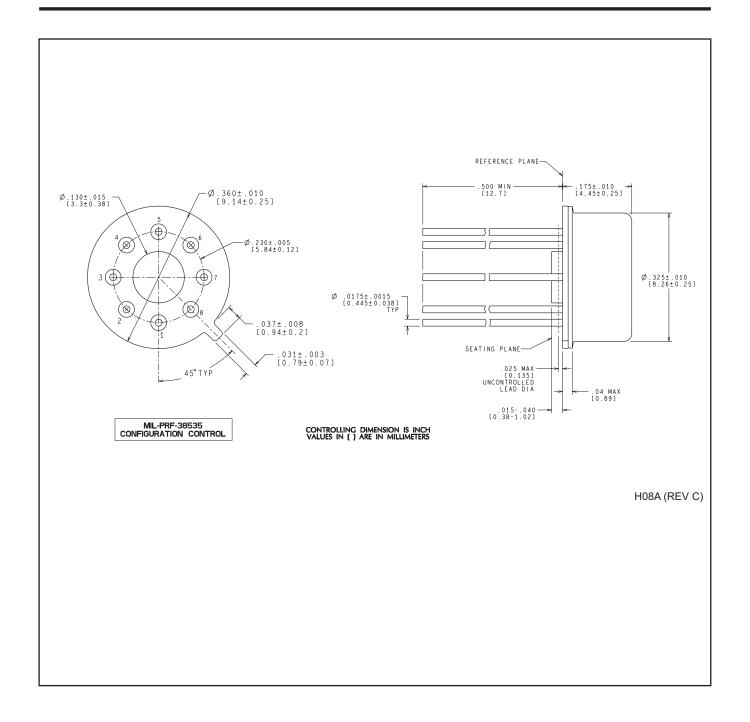
Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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⁽⁴⁾ Only one of markings shown within the brackets will appear on the physical device.



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